## Notice of References Cited Application/Control No. 10/516,829 Examiner Jonathan Moffat Applicant(s)/Patent Under Reexamination HEIN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*	-	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,786,994	07-1998	Friz et al.	700/79
*	В	US-6,505,966	01-2003	Guru, Shankar Visvanathan	378/207
*	С	US-5,220,589	06-1993	Gard, Michael F.	378/19
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	v							
	w							
	х							

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